TOSHIBA Transistor Silicon PNP Epitaxial Type

# 2SB1481

### **Switching Applications**

- High DC current gain:  $h_{FE} = 2000$  (min) ( $V_{CE} = -2$  V,  $I_{C} = -1.5$  A)
- Low saturation voltage:  $V_{CE (sat)} = -1.5 \text{ V (max) (IC} = -3 \text{ A)}$
- Complementary to 2SD2241

#### Absolute Maximum Ratings (Tc = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V <sub>CBO</sub>	-100	$\langle \mathcal{N} \rangle$	
Collector-emitter voltage		V <sub>CEO</sub>	-100	$\langle \langle \psi \rangle \rangle$	
Emitter-base voltage		V <sub>EBO</sub>	-5	)>	
Collector current	DC	Ic	±4	> A	
	Pulse	I <sub>CP</sub>	±6		
Base current		I <sub>B</sub>	-0.3	Α	
Collector power dissipation	Ta = 25°C	D- <	2:0	W	
	Tc = 25°C	PC	25	<<	
Junction temperature		Tj(	150	°C/	
Storage temperature range		T <sub>stg</sub>		°C	

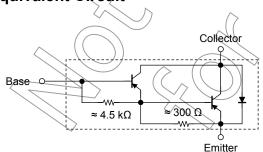
Weight: 1.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high

temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

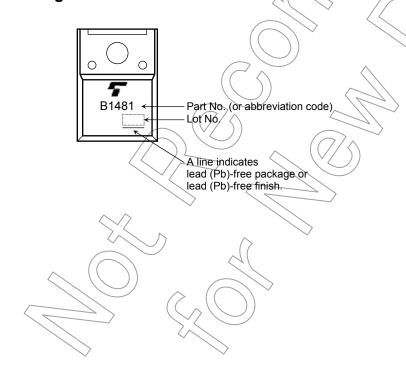
## Equivalent Circuit



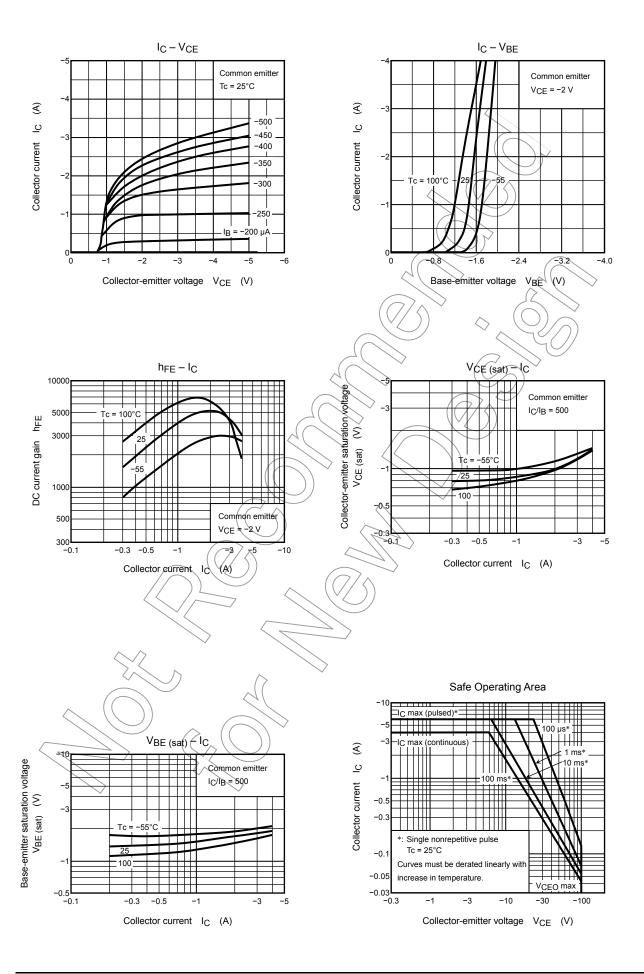
## Electrical Characteristics (Tc = 25°C)

Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off of	current	I <sub>CBO</sub>	V <sub>CB</sub> = -100 V, I <sub>E</sub> = 0	_	_	-2.0	μΑ
Emitter cut-off current		I <sub>EBO</sub>	V <sub>EB</sub> = -5 V, I <sub>C</sub> = 0	_	_	-2.5	mA
Collector-emitter breakdown voltage V		V (BR) CEO	I <sub>C</sub> = -10 mA, I <sub>B</sub> =0	-100	-	_	V
DC current gain		h <sub>FE (1)</sub>	V <sub>CE</sub> = -2 V, I <sub>C</sub> = -1.5 A 2000			-	
		h <sub>FE (2)</sub>	V <sub>CE</sub> = -2 V, I <sub>C</sub> = -3 A	1000	) }_	_	
Collector-emitter	Collector-emitter saturation voltage $V_{CE (sat)}$ $I_{C} = -3 \text{ A}, I_{B} = -6 \text{ mA}$		)   	_	-1.5	V	
Base-emitter saturation voltage V		V <sub>BE (sat)</sub>	$I_C = -3 \text{ A}, I_B = -6 \text{ mA}$	$\rightarrow$	-	-2.0	V
Collector-emitter reverse voltage		V <sub>CEO</sub>	I <sub>C</sub> = 1 A, I <sub>B</sub> = 0	_	_	2.0	V
Switching time S	Turn-on time	t <sub>on</sub>	20 μs	_	0.15	1//	µs
	Storage time	t <sub>stg</sub>	Input B₁ C C C C C C C C C C C C C C C C C C		0.80	> _	
	Fall time	t <sub>f</sub>	$V_{CC} \approx -30 \text{ V}$ $-I_{B1} = I_{B2} = 6 \text{ mA}, \text{ duty cycle} \le 1\%$		0.40		





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